



YOUSHANG SEMICONDUCTOR

**设计研发新型功率器件**

**各类小信号开关**

**中低压及高压大电流等场效应管**

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企业微信二维码



企业QQ二维码

## Product Summary

$BV_{DSS}$	$R_{DS(ON) MAX}$	$I_D$ $T_A = 25^\circ C$
200V	750m $\Omega$ @ $V_{GS} = 10V$	2.3A
	780m $\Omega$ @ $V_{GS} = 5V$	2.2A

## Features and Benefits

- 100% Unclamped Inductive Switch (UIS) test in production
- High avalanche energy pulse withstand capability
- Low gate drive voltage (Logic level capable)
- Low input capacitance
- Low on-resistance
- Fast switching speed

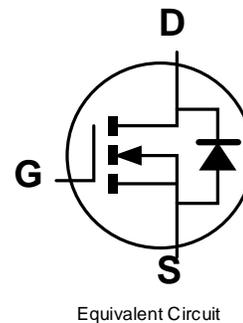
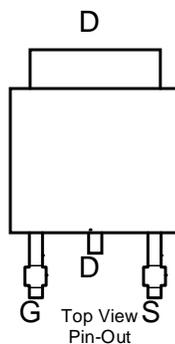
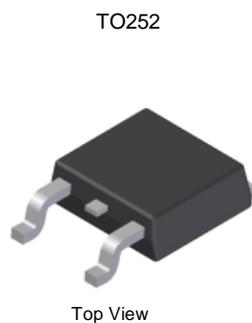
## Description and Applications

This MOSFET features low on-resistance, fast switching and a high avalanche withstand capability, making it ideal for high-efficiency power management applications.

- SLIC line drivers for VoIP applications
- Transformer driving switch
- Power management functions
  - Motor control
  - Uninterrupted power supply

## Mechanical Data

- Case: TO252
  - Case Material: Molded Plastic "Green" Molding Compound, UL Flammability Classification Rating 94V-0 (Note 1)
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
  - Terminals: Matte Tin Finish Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.33 grams (Approximate)



**Maximum Ratings** (@ $T_A = 25^\circ\text{C}$ , unless otherwise specified)

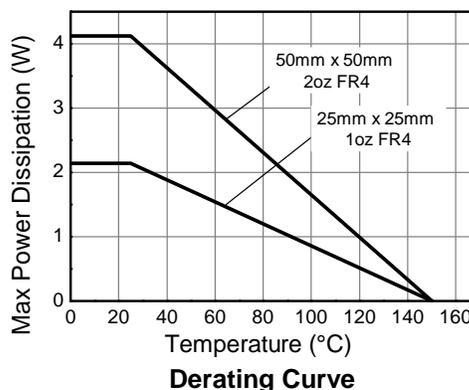
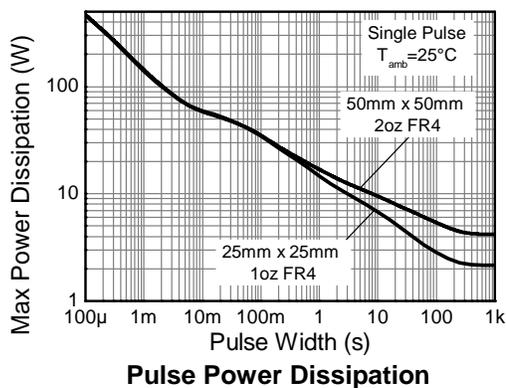
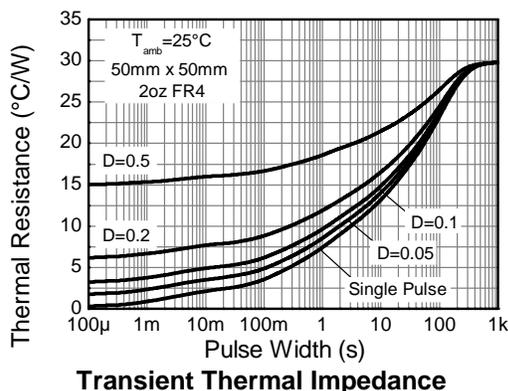
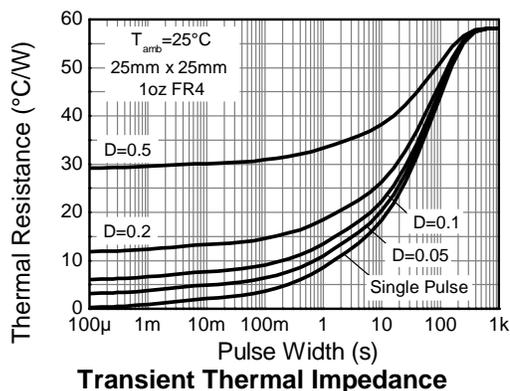
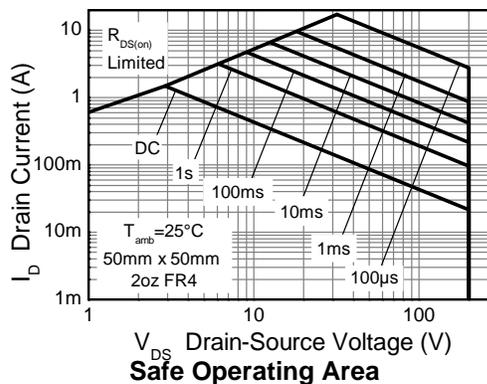
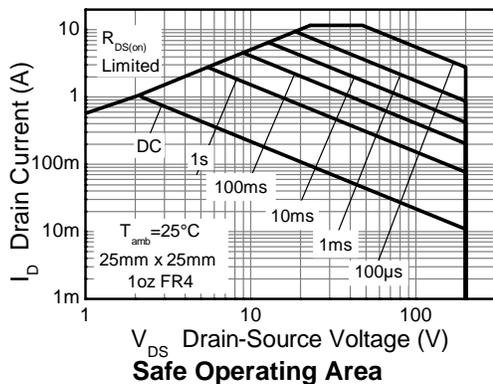
Characteristic		Symbol	Value	Unit	
Drain-Source voltage		$V_{DSS}$	200	V	
Gate-Source voltage		$V_{GS}$	$\pm 20$	V	
Single Pulsed Avalanche Energy	(Note 10)	$E_{AS}$	73	mJ	
Single Pulsed Avalanche Current	(Note 10)	$I_{AS}$	5.5	A	
Repetitive Avalanche Energy	(Note 7)	$E_{AR}$	4.5	mJ	
Repetitive Avalanche Current	(Note 7)	$I_{AR}$	5.5	A	
Continuous Drain current	$V_{GS} = 10\text{V}$ $T_A = 70^\circ\text{C}$ (Note 6) (Note 5)	$I_D$	2.3	A	
			1.8		
Pulsed Drain current	$V_{GS} = 10\text{V}$ (Note 7)	$I_{DM}$	17.3	A	
Continuous Source current (Body diode)		(Note 5)	$I_S$	2.3	A
Pulsed Source current (Body diode)		(Note 7)	$I_{SM}$	17.3	A

**Thermal Characteristics** (@  $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Power dissipation Linear derating factor	(Note 5)	$P_D$	4.3	W mW/ $^\circ\text{C}$
			34.4	
	(Note 6)		10.2	
			76.0	
Thermal Resistance, Junction to Ambient	(Note 5)	$R_{\theta JA}$	2.2	$^\circ\text{C}/\text{W}$
			17.4	
	(Note 6)		29.1	
Thermal Resistance, Junction to Lead	(Note 6)	$R_{\theta JL}$	12.3	$^\circ\text{C}/\text{W}$
	(Note 9)		57.3	
Operating and storage temperature range		$T_J, T_{STG}$	-55 to 150	$^\circ\text{C}$

- Notes:
5. For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
  6. Same as note 2, except the device is measured at  $t \leq 10$  sec.
  7. Same as note 2, except the device is operating in a repetitive state with pulse width and duty cycle limited by maximum junction temperature.
  8. Thermal resistance from junction to solder-point (at the end of the drain lead).
  9. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with the high coverage single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
  10. UIS in production with  $L = 4.83\text{mH}$ ,  $I_{AS} = 5.5\text{A}$ ,  $R_G = 25\Omega$ ,  $V_{DD} = 100\text{V}$ , starting  $T_J = 25^\circ\text{C}$ .

**Thermal Characteristics**

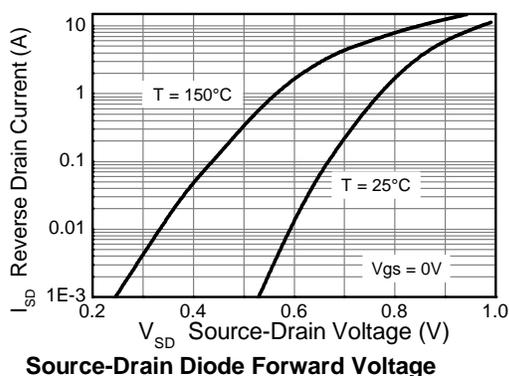
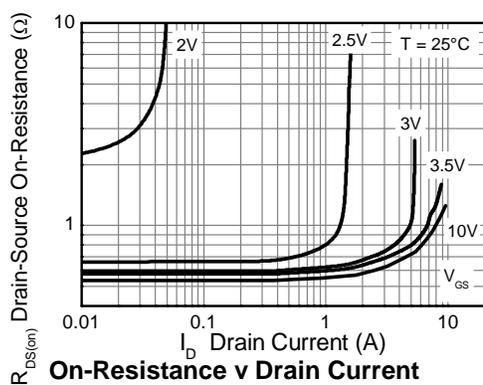
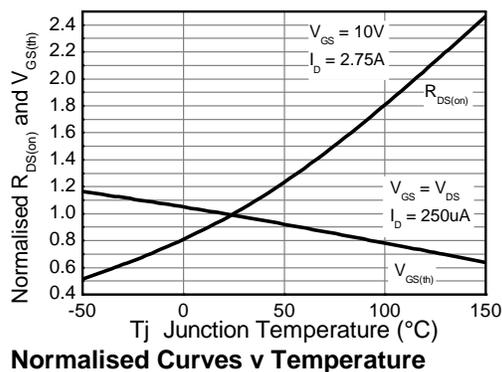
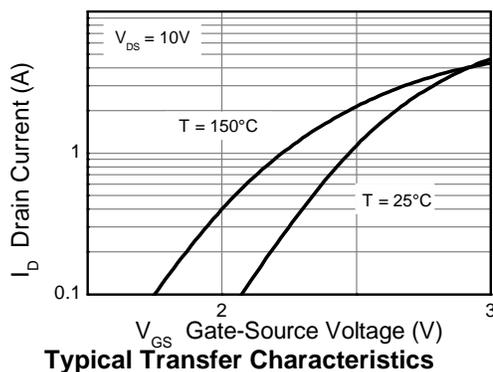
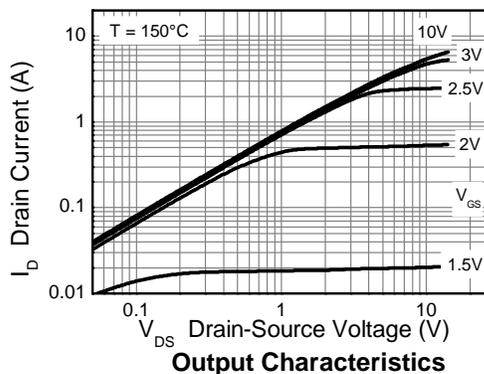
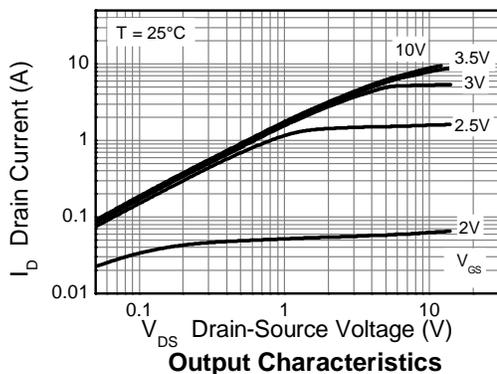


**Electrical Characteristics** (@ $T_A = 25^\circ\text{C}$ , unless otherwise specified.)

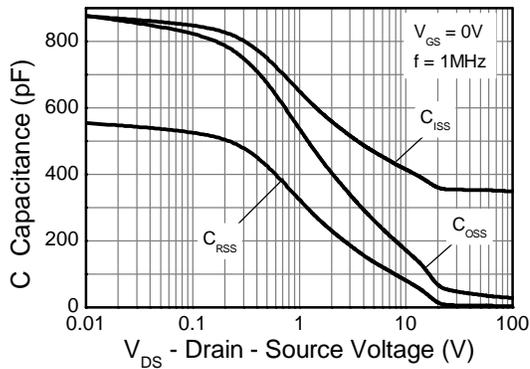
Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 11)</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	200	—	—	V	$I_D = 250\mu\text{A}$ , $V_{GS} = 0\text{V}$
Zero Gate Voltage Drain Current	$I_{DSS}$	—	—	500	nA	$V_{DS} = 200\text{V}$ , $V_{GS} = 0\text{V}$
Gate-Source Leakage	$I_{GSS}$	—	—	$\pm 100$	nA	$V_{GS} = \pm 20\text{V}$ , $V_{DS} = 0\text{V}$
<b>ON CHARACTERISTICS (Note 11)</b>						
Gate Threshold Voltage	$V_{GS(th)}$	1	1.6	2.5	V	$I_D = 250\mu\text{A}$ , $V_{DS} = V_{GS}$
Static Drain-Source On-Resistance (Note 12)	$R_{DS(on)}$	—	0.650	0.750	$\Omega$	$V_{GS} = 10\text{V}$ , $I_D = 2.75\text{A}$
			0.670	0.780		$V_{GS} = 5\text{V}$ , $I_D = 2.75\text{A}$
Forward Transconductance (Notes 12 & 13)	$g_{fs}$	—	6.13	—	S	$V_{DS} = 30\text{V}$ , $I_D = 2.75\text{A}$
Diode Forward Voltage (Note 12)	$V_{SD}$	—	0.860	0.950	V	$I_S = 5.5\text{A}$ , $V_{GS} = 0\text{V}$
Reverse recovery time (Note 13)	$t_{rr}$	—	177	—	ns	$I_S = 6.5\text{A}$ , $V_{GS} = 0\text{V}$ ,
Reverse recovery charge (Note 13)	$Q_{rr}$	—	1.4	—	$\mu\text{C}$	$di/dt = 100\text{A}/\mu\text{s}$
<b>DYNAMIC CHARACTERISTICS (Note 13)</b>						
Input Capacitance	$C_{iss}$	—	358	—	pF	$V_{DS} = 25\text{V}$ , $V_{GS} = 0\text{V}$ $f = 1\text{MHz}$
Output Capacitance	$C_{oss}$	—	50	—	pF	
Reverse Transfer Capacitance	$C_{rss}$	—	6.1	—	pF	
Total Gate Charge	$Q_g$	—	8.1	—	nC	$V_{DS} = 120\text{V}$ , $V_{GS} = 5\text{V}$ $I_D = 6.5\text{A}$
Gate-Source Charge	$Q_{gs}$	—	1.4	—	nC	
Gate-Drain Charge	$Q_{gd}$	—	3.9	—	nC	
Turn-On Delay Time (Note 14)	$t_{D(on)}$	—	17.8	—	ns	$V_{DD} = 100\text{V}$ , $V_{GS} = 5\text{V}$ $I_D = 6.5\text{A}$ , $R_G \cong 25\Omega$
Turn-On Rise Time (Note 14)	$t_r$	—	76.9	—	ns	
Turn-Off Delay Time (Note 14)	$t_{D(off)}$	—	44.7	—	ns	
Turn-Off Fall Time (Note 14)	$t_f$	—	57.1	—	ns	

- Notes:
11. Short duration pulse test used to minimize self-heating effect.
  12. Measured under pulsed conditions. Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$
  13. For design aid only, not subject to production testing.
  14. Switching characteristics are independent of operating junction temperatures.

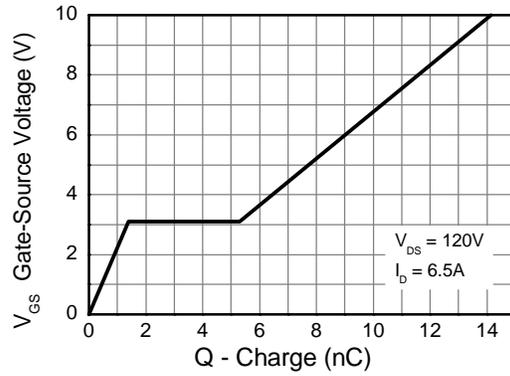
Typical Characteristics



**Typical Characteristics** (continued)

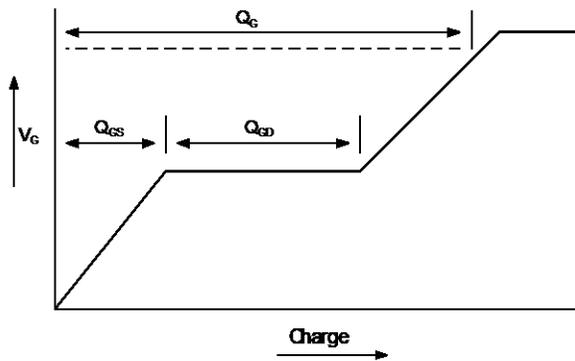


**Capacitance v Drain-Source Voltage**

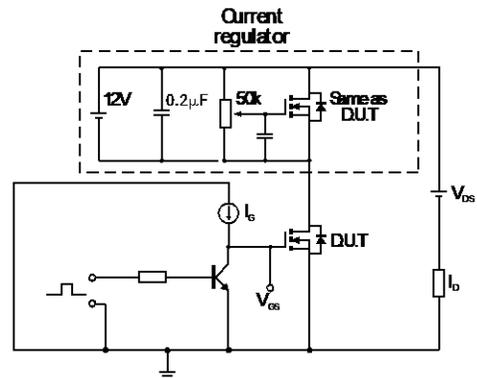


**Gate-Source Voltage v Gate Charge**

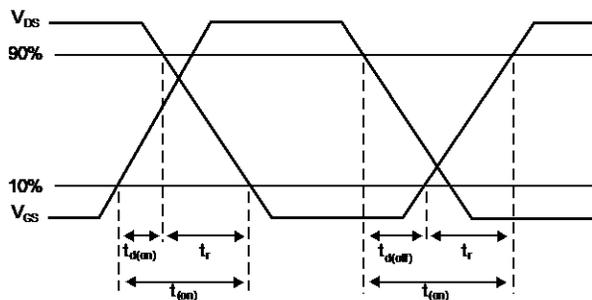
**Test Circuits**



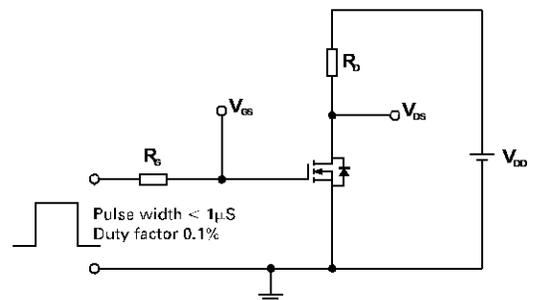
**Basic gate charge waveform**



**Gate charge test circuit**



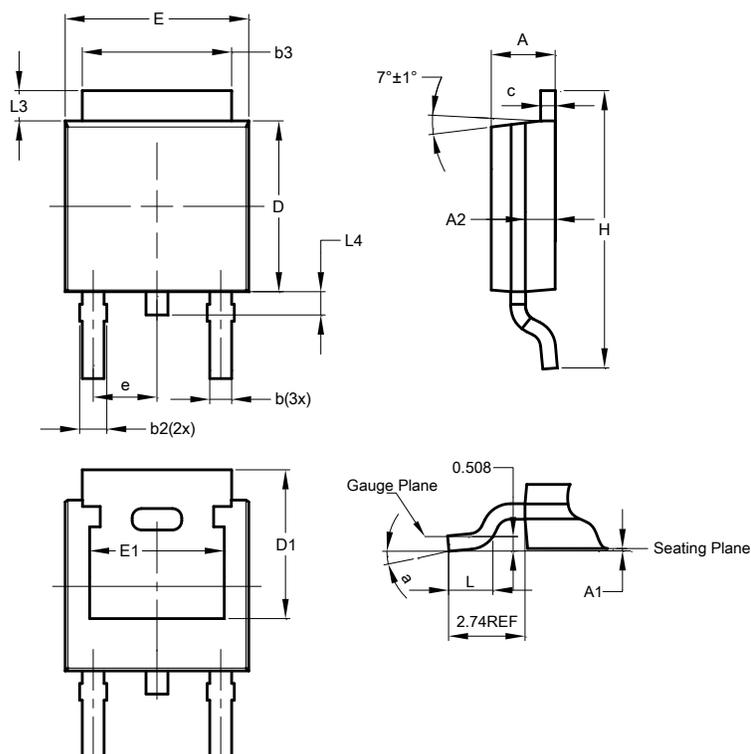
**Switching time waveforms**



**Switching time test circuit**

### Package Outline Dimensions

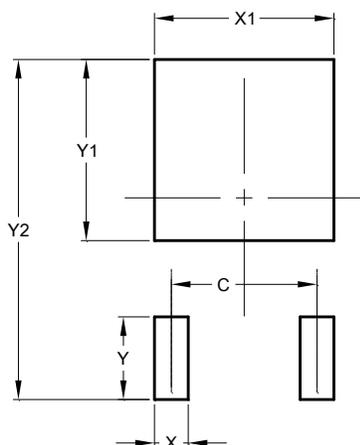
TO252 (DPAK)



TO252 (DPAK)			
Dim	Min	Max	Typ
A	2.19	2.39	2.29
A1	0.00	0.13	0.08
A2	0.97	1.17	1.07
b	0.64	0.88	0.783
b2	0.76	1.14	0.95
b3	5.21	5.46	5.33
c	0.45	0.58	0.531
D	6.00	6.20	6.10
D1	5.21	-	-
e	-	-	2.286
E	6.45	6.70	6.58
E1	4.32	-	-
H	9.40	10.41	9.91
L	1.40	1.78	1.59
L3	0.88	1.27	1.08
L4	0.64	1.02	0.83
a	0°	10°	-
All Dimensions in mm			

### Suggested Pad Layout

TO252 (DPAK)



Dimensions	Value (in mm)
C	4.572
X	1.060
X1	5.632
Y	2.600
Y1	5.700
Y2	10.700